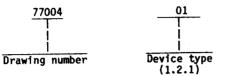
REVISIONS DATE **APPROVED** DESCRIPTION LTR 31 Aug 1987 Delete vendors, CAGE 18324, CAGE 34335, and CAGE 07263. Change in terminal connections and truth table. Add logic diagram. Revise to military drawing format. Change code ident. no. DEVICE 01 INACTIVE FOR NEW DESIGN AS OF 25 DEC 1981. USE M38510/07702B--. REV PAGE D D D D D D REV D ۵ D D **REV STATUS** OF PAGES PAGES ITARY DRAWING **Defense Electronics** This drawing is available for use by **Supply Center** all Departments and Agencies of the BY Dayton, Ohio Department of Defense TITLE: MICROCIRCUIT, DIGITAL, BIPOLAR SCHOTTKY TTL, DECODER, MONOLITHIC Original date of drawing: SILICON 23 FEB 1977 CODE IDENT. NO. DWG NO. SIZE 67268 Α 11 PAGE REV 1 AMSC N/A D 5962-E278

DISTRIBUTION STATEMENT A. Approved for public release; distribution is unlimited.

DESC FORM 193

MAY 86

- 1.1 Scope. This drawing describes device requirements for class B microcircuits in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with compliant non-JAN
 - 1.2 Part number. The complete part number shall be as shown in the following example:







1.2.1 Device type. The device type shall identify the circuit function as follows:

Device type

Generic number

Circuit function

01

54\$139

Dual 2 to 4 line decoder/demultiplexer

1.2.2 Case outlines. The case outlines shall be as designated in appendix C of MIL-M-38510, and as follows:

Outline letter

Case outline

E

D-2 (16-lead, 1/4" X 7/8"), dual-in-line package F-5 (16-lead, 1/4" X 3/8"), flat package

1.3 Absolute maximum ratings.

Supply voltage range - - - - - - - - - -Input voltage range- - - - - - - - - - - -Storage temperature range- - - - - - - - -Maximum power dissipation (P_D) per device $\frac{1}{-}$ - Lead temperature (soldering, 10 seconds) - $\frac{1}{-}$ -Thermal resistance, junction-to-case (θ_{JC}) - - -Cases E and F -----Junction temperature (T_{ij}) - - - - - - - - -

-0.5 V dc to +7.0 V dc -1.2 V dc at -18 mA to +5.5 V dc -65°C to +150°C

495 mW +300°C

See MIL-M-38510, appendix C +175°C

1.4 Recommended operating conditions.

Supply voltage (VCC) - - - - -Minimum high level input voltage (VIH) - - - - Maximum low level input voltage (VIL) - - - - - Case operating temperature range (TC) - - - - - 4.5 V dc minimum to 5.5 V dc maximum

2.0 V dc

0.8 V dc -55°C to +125°C

1/ Must withstand the added Pp due to short circuit test (e.g., Ios).

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2. APPLICABLE DOCUMENTS

2.1 Government specification and standard. Unless otherwise specified, the following specification and standard, of the issue listed in that issue of the Department of Defense Index of Specifications and Standards specified in the solicitation, form a part of this drawing to the extent specified herein.

SPECIFICATION

MILITARY

MIL-M-38510

- Microcircuits, General Specification for.

STANDARD

MILITARY

MIL-STD-883

Test Methods and Procedures for Microelectronics.

(Copies of the specification and standard required by manufacturers in connection with specific acquisition functions should be obtained from the contracting activity or as directed by the contracting activity.)

2.2 Order of precedence. In the event of a conflict between the text of this drawing and the references cited herein, the text of this drawing shall take precedence.

3. REQUIREMENTS

- 3.1 Item requirements. The individual item requirements shall be in accordance with 1.2.1 of MIL-STD-883, "Provisions for the use of MIL-STD-883 in conjunction with complaint non-JAN devices" and as specified herein.
- 3.2 Design, construction, and physical dimensions. The design, construction, and physical dimensions shall be as specified in MIL-M-38510 and herein.
 - 3.2.1 Terminal connections. The terminal connections shall be as specified on figure 1.
 - 3.2.2 Truth table. The truth table shall be as specified on figure 2.
 - 3.2.3 Logic diagram. The logic diagram shall be as specified on figure 3.
 - 3.2.4 Case outlines. The case outlines shall be in accordance with 1.2.2 herein.
- 3.3 Electrical performance characteristics. Unless otherwise specified, the electrical performance characteristics are as specified in table I and apply over the full recommended case operating temperature range.
- 3.4 Marking. Marking shall be in accordance with MIL-STD-883 (see 3.1 herein). The part shall be marked with the part number listed in 1.2 herein. In addition, the manufacturer's part number may also be marked as listed in 6.4 herein.
- 3.5 Certificate of compliance. A certificate of compliance shall be required from a manufacturer in order to be listed as an approved source of supply in 6.4. The certificate of compliance submitted to DESC-ECS prior to listing as an approved source of supply shall state that the manufacturer's product meets the requirements of MIL-STD-883 (see 3.1 herein) and the requirements herein.
- 3.6 Certificate of conformance. A certificate of conformance as required in MIL-STD-883 (see 3.1 herein) shall be provided with each lot of microcircuits delivered to this drawing.

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T	Sumb al	Conditions	Group A	Limits		Unit	
Test	Symbol	Conditions -55°C < T _C < +125°C unless otherwise specified	subgroups	Min	Max		
High-level output voltage	! ¥ _{OH} 	V _{CC} = 4.5 V; I _{OH} = -1.0 mA V _I H = 2.0 V V _I L = 0.8 V	1, 2, 3	2.5 		V 	
Low-level output voltage	V _{OL}	V _{CC} = 4.5 Y; I _{OL} = 20 mA V _{IH} = 2.0 V V _{IL} = 0.8 V	1, 2, 3	 	0,5	V 	
Input clamp voltage	IV _{IC}	V _{CC} = 4.5 V; I _{IN} = -18 mA	1	 	 -1.2 	V	
High-level input current	I IH1	V _{CC} = 5.5 V; V _{IH} = 2.7 V	1, 2, 3	 	 50 	 μΑ 	
	I IH2	V _{CC} = 5.5 V; V _{IH} = 5.5 V	1, 2, 3	!	1.0	l mA	
Low-level input current	IIIL	V _{CC} = 5.5 V; V _{IL} = 0.5 V	1, 2, 3	! !	1-2.0	Am A	
Short-circuit output current	Ios	V _{CC} = 5.5 V V _{out} = 0.0 V <u>1</u> /	1, 2, 3	 -40 	-100	 mA 	
Supply current	1 _{CC}	VCC = 5.5 V	1, 2, 3	1 	90	mA	
Functional tests		See 4.3.1c	7			1	
Propagation delay time, output from binary select	tpHL1	$ V_{CC} = 5.0 \text{ V}$ $ C_L = 15 \text{ pF } \pm 10$ $ R_L = 280 \Omega \pm 5^{\circ}$)% 9 	 	1 10	ns	
to any 2 levels of delay	 	2/	10, 11		1 14	l ns	
)* 9		1 19	l ns	
	İ		10, 11		27	ns	

See footnotes at end of table.

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				<u> </u>	Limi	ts	IInd A
Test	Symbol 	Condi -55°C < TC unless otherw	< +125°C	Group A subgroups	Min	Max	Unit
output from binary select	y select $ R = 280\Omega \pm 5\%$		9		8	ns	
to any 2 levels of delay		! <u>2/</u> !	 	10, 11		11	ns
	 	 	$ C_L = 50 \text{ pF } \pm 10^{\circ}$	9	1	13	ns
	! 	 		10, 11		18	ns
output from binary select	 t _{PHL2} 	T 	C _L = 15 pF ±10°	 9 		12	ns
to any 3 levels of delay	 	1		10, 11	! !	17	ns
	t _{PLH2}		CL = 50 pF ±10°	 9 	 	17	ns
					10, 11	 	24
•		t _{PLH2} C _L = 15 pF ±10	C _L = 15 pF ±10%	9		12	ns
			[[10, 11		17	l ns
	[CL = 50 pF ±10°	 9 	 	17	ns
	 			10, 11	 	24	l ns
Propagation delay time, output from enable to any		C _L = 15 pF ±10%	9	1	10	l ns	
2 levels of delay	 	1 1	! !	10, 11	! 	1 14	ns
	 	 		 9 		15	l I ns
	j I	į Į	!	10, 11		21	ns

See footnotes at end of table.

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				Group A	Limi	Limits		
Test	Symbol 	Condi -55°C < To unless otherw	tions < +125°C rise specified	subgroups	Min	Max	Unit 	
Propagation delay time, output from enable to an	t _{PLH3}	V _{CC} = 5.0 V R _L = 280Ω ±5%	C _L = 15 pF ±10°	9		8	ns	
2 levels of delay] 	2/		10, 11	 	 11 	l l ns	
	1		C _L = 50 pF ±10%	 9 		 13 	l ns	
	į		į	1 10, 11		1 18	l ns	

^{1/} Not more than one output should be shorted at a time, and the duration of the short circuit condition should not exceed one second.

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^{2/} Propagation delay time testing may be performed using either $C_L = 15$ pF or $C_L = 50$ pF. However, the manufacturer must certify and guarantee that the microcircuits meet the switching test limits specified for a 50 pF load.

- 3.7 Notification of change. Notification of change to DESC-ECS shall be required in accordance with MIL-STD-883 (see 3.1 herein).
- 3.8 Verification and review. DESC, DESC's agent, and the acquiring activity retain the option to review the manufacturer's facility and applicable required documentation. Offshore documentation shall be made available onshore at the option of the reviewer.
 - 4. QUALITY ASSURANCE PROVISIONS
- 4.1 Sampling and inspection. Sampling and inspection procedures shall be in accordance with section 4 of MIL-M-38510 to the extent specified in MIL-STD-883 (see 3.1 herein).
- 4.2 <u>Screening</u>. Screening shall be in accordance with method 5004 of MIL-STD-883, and shall be conducted on all devices prior to quality conformance inspection. The following additional criteria shall apply:
 - a. Burn-in test (method 1015 of MIL-STD-883).
 - Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - b. Interim and final electrical test parameters shall be as specified in table II herein, except interim electrical parameter tests prior to burn-in are optional at the discretion of the manufacturer.
- 4.3 Quality conformance inspection. Quality conformance inspection shall be in accordance with method 5005 of MIL-SID-883 including groups A, B, C, and D inspections. The following additional criteria shall apply.
 - 4.3.1 Group A inspection.
 - a. Tests shall be as specified in table II herein.
 - b. Subgroups 4, 5, 6, and 8 in table I, method 5005 of MIL-STD-883 shall be omitted.
 - c. Subgroup 7 tests shall verify the truth table.
 - 4.3.2 Groups C and D inspections.
 - a. End-point electrical parameters shall be as specified in table II herein.
 - b. Steady-state life test (method 1005 of MIL-STD-883) conditions:
 - (1) Test condition A, B, C, or D using the circuit submitted with the certificate of compliance (see 3.5 herein).
 - (2) $T_A = +125^{\circ}C$, minimum.
 - (3) Test duration: 1,000 hours, except as permitted by appendix B of MIL-M-38510 and method 1005 of MIL-STD-883.

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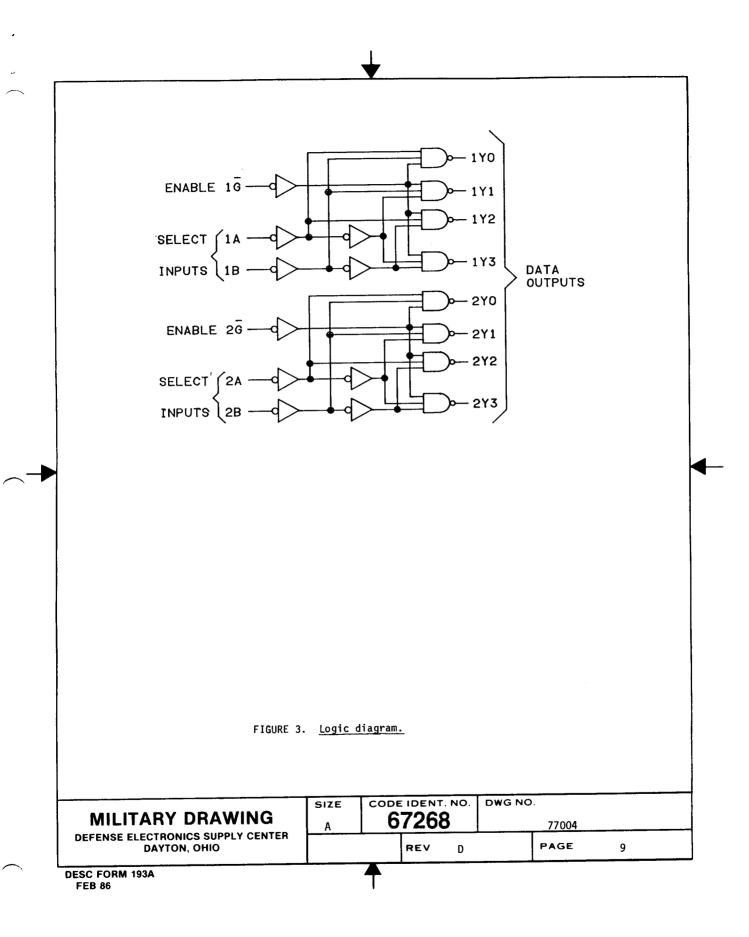


TABLE II. Electrical test requirements.

MIL-STD-883 test requirements	Subgroups (per method 5005, table I)
Interim electrical parameters (method 5004) 	
	1*, 2, 3, 9
Group A test requirements (method 5005)	1, 2, 3, 7, 9, 1 10, 11**
Groups C and D end-point l electrical parameters (method 5005)	1, 2, 3

* PDA applies to subgroup 1. ** Subgroups 10 and 11, if not tested, shall be guaranteed to the specified limits in table I.

5. PACKAGING

- 5.1 Packaging requirements. The requirements for packaging shall be in accordance with MIL-M-38510.
- 6. NOTES
- 6.1 Intended use. Microcircuits conforming to this drawing are intended for use when military specifications do not exist and qualified military devices that will perform the required function are not available for OEM application. When a military specification exists and the product covered by this drawing has been qualified for listing on QPL-38510, the device specified herein will be inactivated and will not be used for new design. The QPL-38510 product shall be the preferred item for all applications.
 - 6.2 Replaceability. Replaceability is determined as follows:
 - a. Microcircuits covered by this drawing will replace the same generic device covered by a contractor-prepared specification or drawing.
 - b. When a QPL source is established, the part numbered device specified in this drawing will be replaced by the microcircuit identified as part number M38510/07702B--.
- 6.3 Comments. Comments on this drawing should be directed to DESC-ECS, Dayton, Ohio 45444, or telephone 513-296-5375.

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6.4 Approved source of supply. An approved source of supply is listed herein. Additional sources will be added as they become available. The vendor listed herein has agreed to this drawing and a certificate of compliance (see 3.5 herein) has been submitted to DESC-ECS.

Military drawing part number	Vendor CAGE number	Vendor similar part number $\frac{1}{4}$	Replacement military specification part number
7700401EX <u>2</u> /	01295	SNJ54S139J	М38510/07702BEX
7700401FX <u>2</u> /	01295	SNJ54S139W	M38510/07702BFX

- 1/ Caution. Do not use this number for item acquisition. Items acquired to this number may not satisfy the performance requirements of this drawing.
- 2/ Inactive for new design. Use QPL-38510 product.

Vendor CAGE number

01295

Vendor name and address

Texas Instruments, Inc. P. O. Box 6448 Midland, TX 79701

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